



## Renishaw TP200 Probe & Module

**Brand: RENISHAW** 

Category: Renishaw Probe Body & Modules

A compact, module-changing probe that uses strain-gauge mechanisms for higher accuracy and longer life than kinematic touch-trigger probes.

## The TP200 system components are:

- TP200 or TP200B probe body (the TP200B is a variant with increased vibration tolerance)
- TP200 stylus module choice of fixed overtravel forces: SF (standard force) or LF (low force)
- PI 200-3 probe interface
- SCR200 stylus change rack
- There is also an EO module (extended overtravel) which has the same overtravel force as the SF but provides

increased operating range and protection in the probe Z-axis.

## Features and benefits

- Strain-gauge technology offers excellent repeatability and precision 3D form measurement
- Zero reseat errors
- No lobing effect
- 6-way measuring capability
- Stylus reach of up to 100 mm (GF styli)
- · Rapid probe module changing without the need to re-qualify the stylus tips
- Life of >10 million triggers

## TP200 / TP200B probe body

The TP200 probe uses micro strain gauge transducers to deliver excellent repeatability and accurate 3D form measurement even with long styli.

The sensor technology gives sub-micron repeatability and eliminates the lobing characteristics encountered with kinematic probes. The solid-state ASIC electronics within the probe ensure reliable operation over millions of trigger points.

The TP200B uses the same technology as TP200 but has been designed to have higher tolerance to vibration. This helps to overcome the problem of 'air' trigger generation which can arise from vibrations transmitted through the CMM or when using long styli with faster positioning speeds.

Please note that we do not recommend the use of TP200B with the LF module or cranked / star styli.

Specification summary	TP200	TP2008
rincipal application	DCC CMM where high accuracy is required.	As TP200 but where 'air' trigger events occur.
lense directions	6-axis: ±X, ±Y, ±Z	6-axis: ±X, ±Y, ±Z
Unidirectional repeatability (20 µm)	Trigger level 1: 0.40 µm (0.000016 in)	Trigger level 1: 0.40 µm (0.000016 in)
	Trigger level 2: 0.50 µm (0.00002 in)	Trigger level 2: 0.50 µm (0.00002 in)
XY (2D) form measurement deviation	Trigger level 1: ±0.80 µm (0.000032 in)	Trigger level 1: ±1 µm (0.00004 in)
	Trigger level 2 ±0.90 µm (0.000036 in)	Trigger level 2: ±1.2 µm (0.000047 in)
XYZ (3D) form measurement deviation	Trigger level 1: ±1 µm (0.00004 in)	Trigger level 1: ±2.50 µm (0.0001 in)
	Trigger level 2: s1.40 µm (0.000056 in)	Trigger level 2: s4 µm (0.00016 in)
Repeatability of stylus change	With SCR200: ±0.50 µm (0.00002 in) max.	Weh SCR200: ±0.50 µm (0.00002 in) max.
	Manual: ±1 µm (0.00004 in) max.	Manual: ±1 µm (0.00004 in) max.
Frigger force (at stylus tip)	XY plane (all modules): 0.02 N	XY plane (all modules): 0.02 N
	Z-axis (all modules): 0.07 N	Z-axis (all modules): 0.07 N
Overtravel force (§ 0.50 mm displacement)	XY plane (SF / 60 module): 0.2 N to 0.4 N	IXY plane (SF / EO module): 0.2 N to 0.4 N
	XY plane (LF module): 0.1 N to 0.15 N	XY plane (LF module): 0.1 N to 0.15 N
	Z-axis (SF / EO module): 4,90 N	Z-axis (SF / EO module): 4.90 N
	Z-axis (LF module): 1.60 N	Z-axis (LF module): 1.60 N
Neight (probe sensor and module)	22 g (0.78 oz)	22 g (0.78 oz)
Assimum extension (if on a PH10 PLUS series head)	300 mm (11.81 in)	300 mm (11.81 in)
Maximum recommended stylus length (M2 styli range)	SF / EO module: 50 mm (1.97 in) speel to 100 mm (3.94 in) GF	SF / 80 module: 50 mm (1.97 in) steel to 100 mm (3.94 in) GR
	LF module: 20 mm (0.79 in) steel to 50 mm (1.97 in) GF	LF module: 20 mm (0.79 in) steel to 50 mm (1.97 in) GF
Aounting method	M8 thread	M8 thread
iultable interface	PI 200-3, UCC	PI 200-3, UCC
Stylus module changing rack	Automatic 50R200	Automatic SCR200
	Manual: MSR1	Manual: MSR1